

Scintillating Materials and SiPM Readout for an Electromagnetic Calorimeter at the EIC

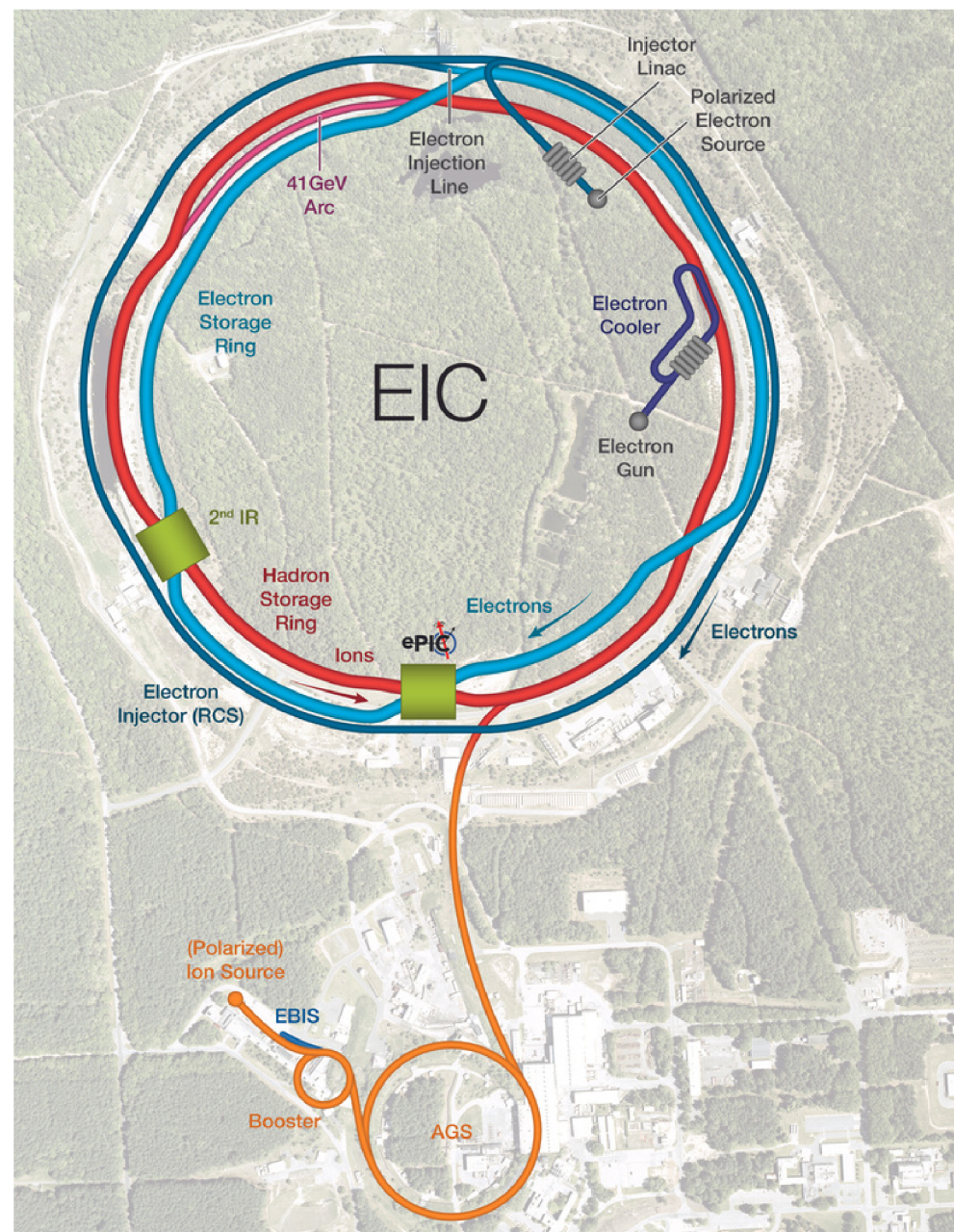
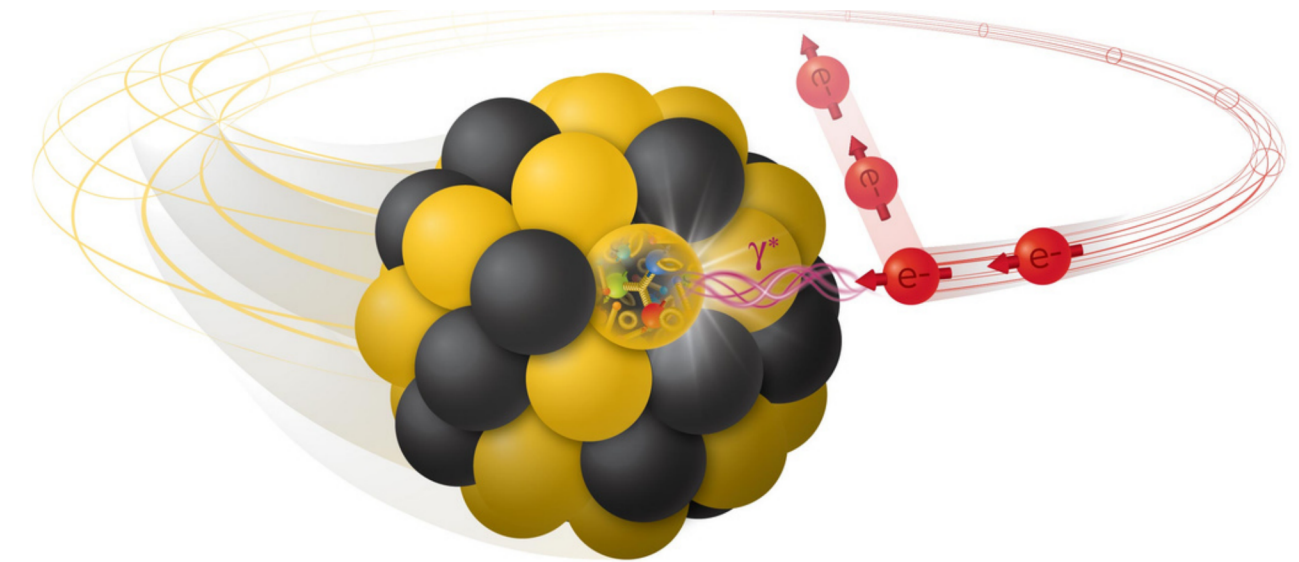
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The Electron Ion Collider and the ePIC detector

Electron-Ion Collider (EIC) at Brookhaven National Lab in the 2030s

- Polarized electron and proton beams.
- Ions from deuterium to heavy nuclei.
- 29–140 GeV e+p center-of-mass energies.
- High luminosity 10^{33} – 10^{34} $\text{cm}^{-2}\cdot\text{s}^{-1}$

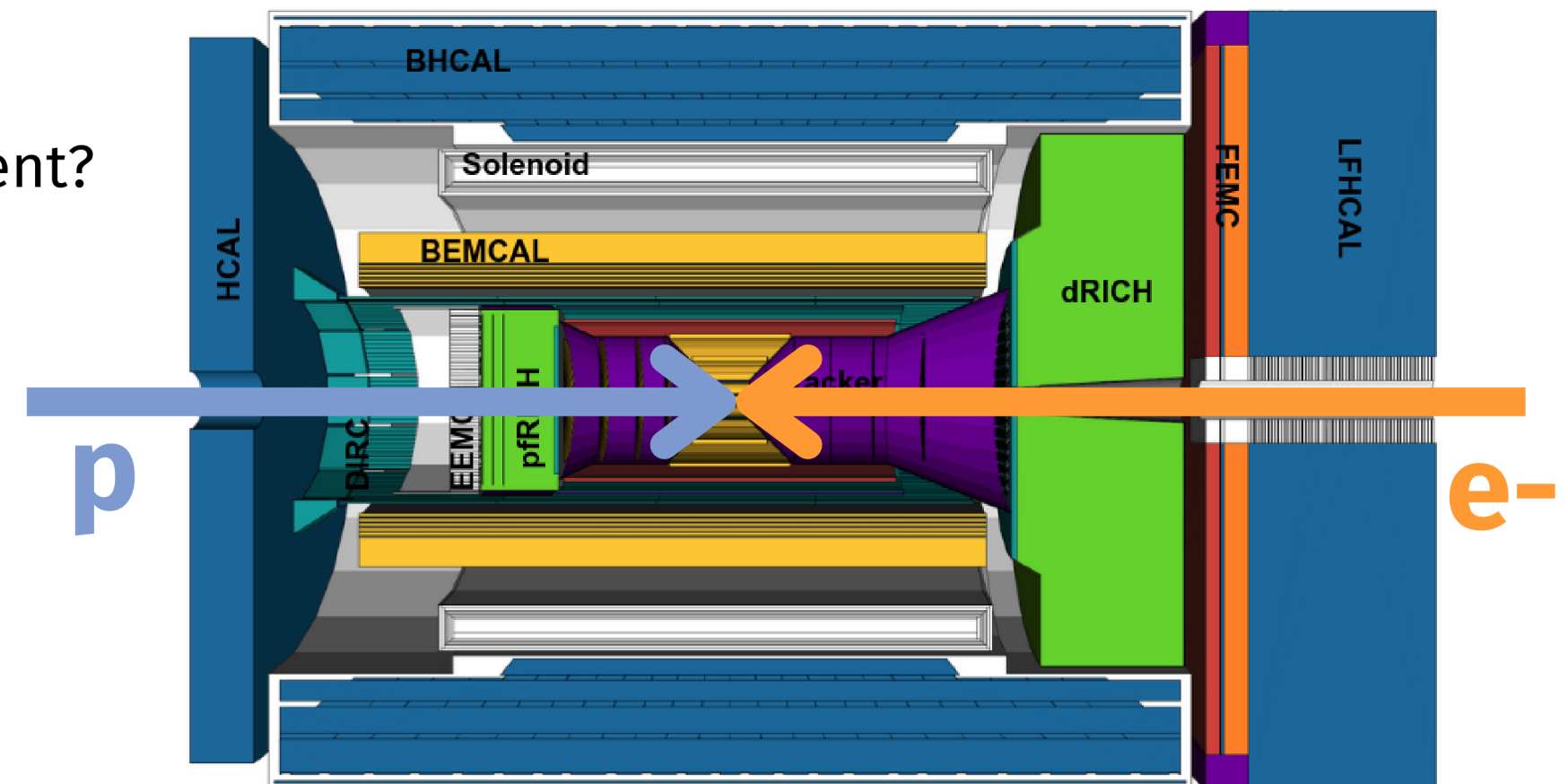


Broad scientific program bringing together medium energy hadronic and high-energy heavy ion communities

- Properties and structure of nucleons?
- Gluon saturation?
- Confinement?
- Nuclear environment?

The ePIC detector:

- Calorimetry
- Tracking
- PID (TOF, RICH,...)



The Electron Endcap Electromagnetic Calorimeter

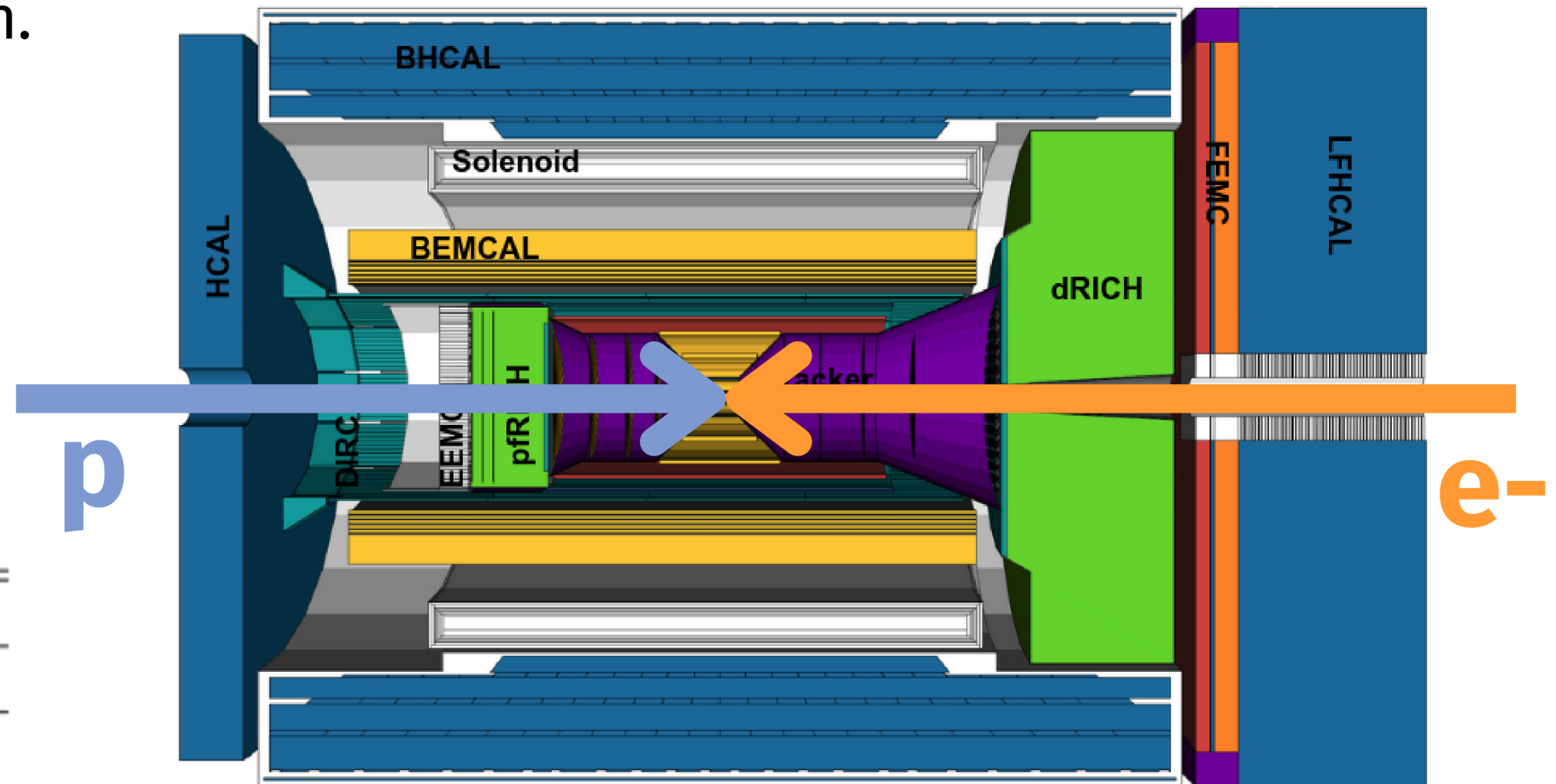
Nearly all processes require detection of the scattered e^- at the EIC.

Physics goals set the requirements for the Electron-Endcap Electromagnetic Calorimeter (EEMC).

- Momentum and energy reconstruction.
- Particle ID.
- π / e^- separation.
- Detection of neutral particles.
- Separation of 2 γ in π_0 decay ...

η	-4 to -2	-2 to -1	-1 to 1	1 to 4
$\sigma_E/E \cdot \sqrt{E/1\text{ GeV}}$	2%	7%	10-12%	10-12%

- Excellent energy resolution
- Large dynamic range : ~5 MeV to ~15 GeV

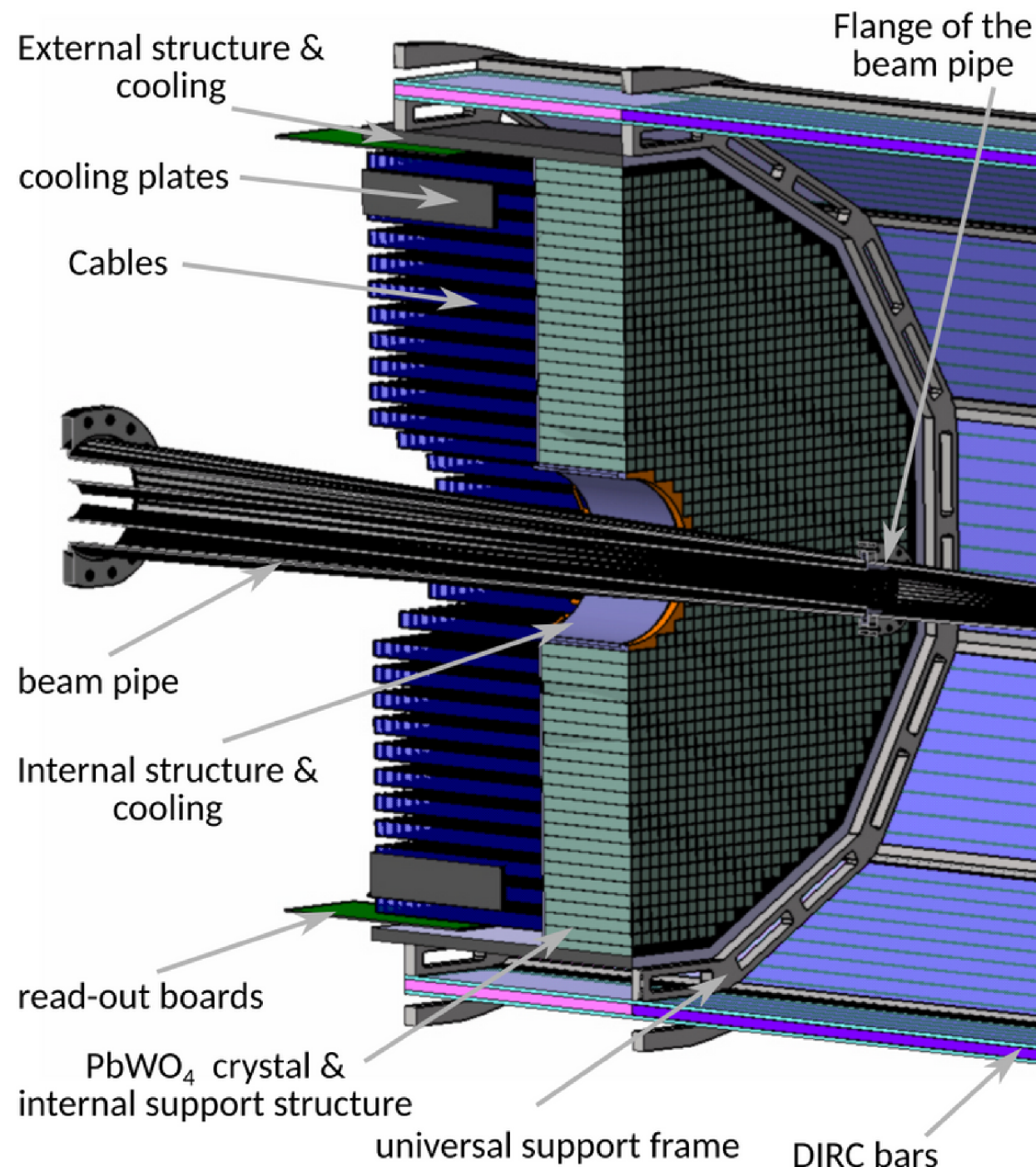


Environment constraints:

- Limited space : compact detector
- Radiation hardness : 30 Gy/year
- Intense magnetic field

The EEMC

3000 PbWO₄ crystals readout by Silicon Photomultipliers (SiPMs).



Scintillating material requirements:

- High energy resolution: high light yield, high transmittance.
- Limited space : short radiation length X_0 .
- Radiation hard.

Readout + electronics :

- Intense magnetic fields: SiPMs.
- Need to collect light on the surface of the crystal : matrix of SiPMs.
- Large dynamic range.

Scintillating Material

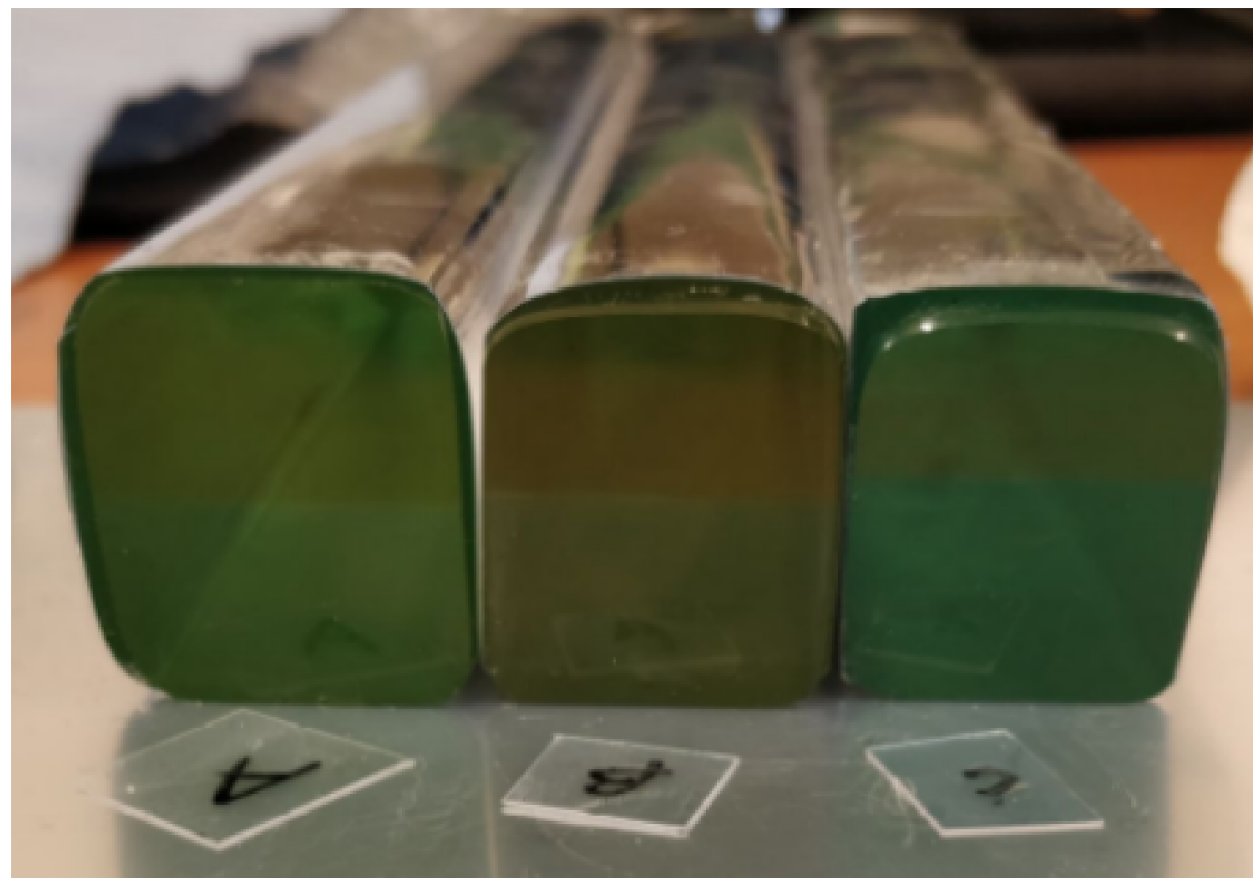
Choice of a scintillating material

Best candidate to meet the requirements: PbWO_4 crystals.

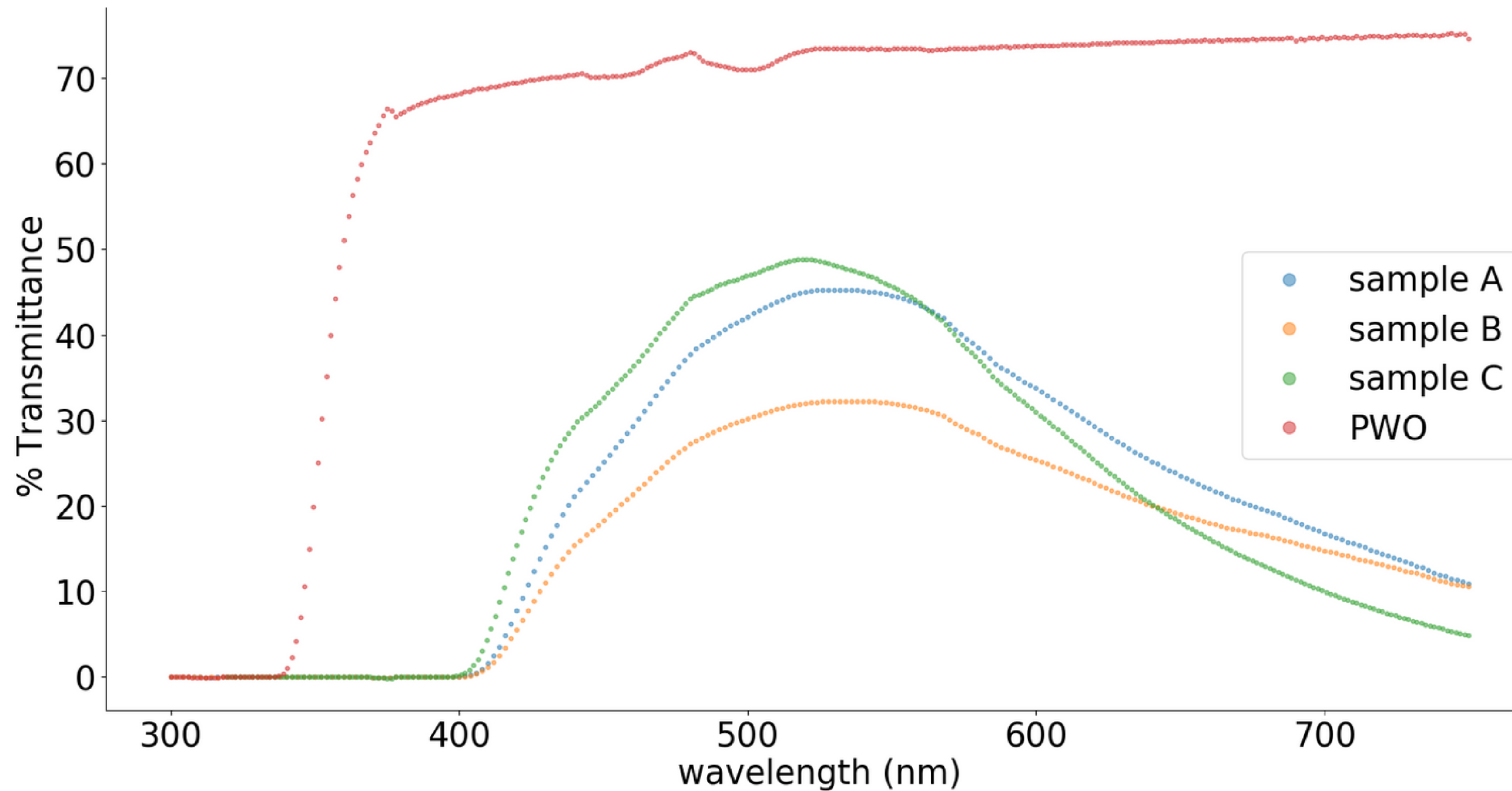
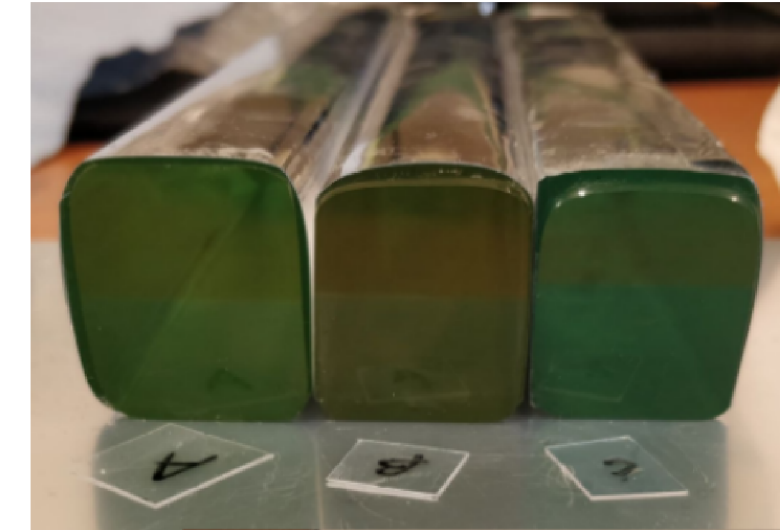
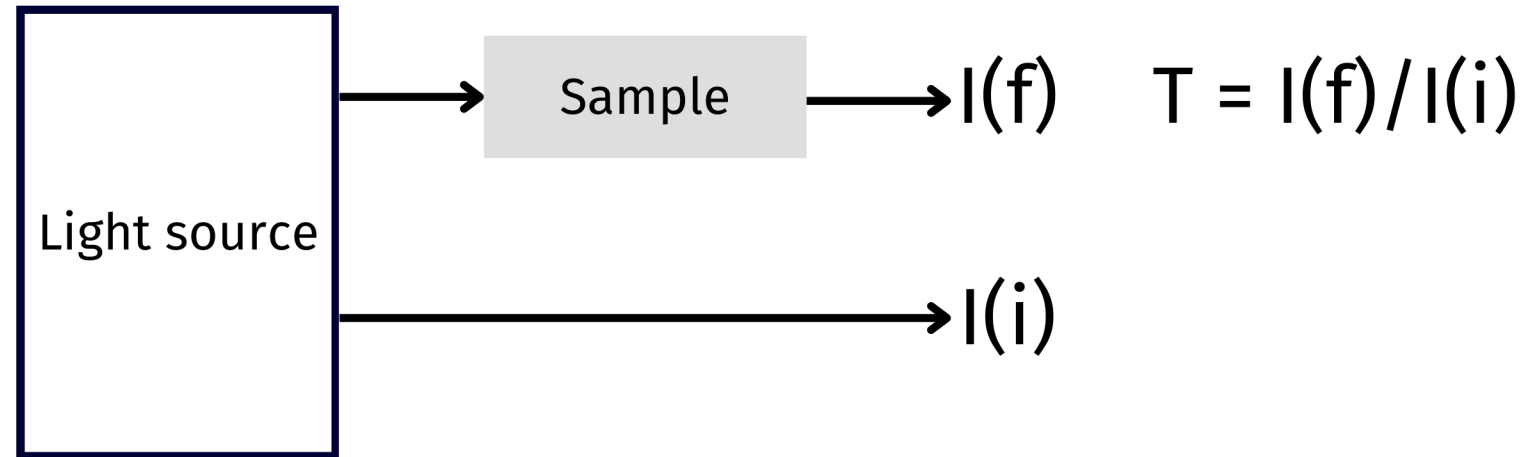
- $X_0 = 8.9$ mm
- Can detect energies as low as 20 MeV photons
- Tested to be radiation hard

Alternative : SciGlass, a new cheaper material.

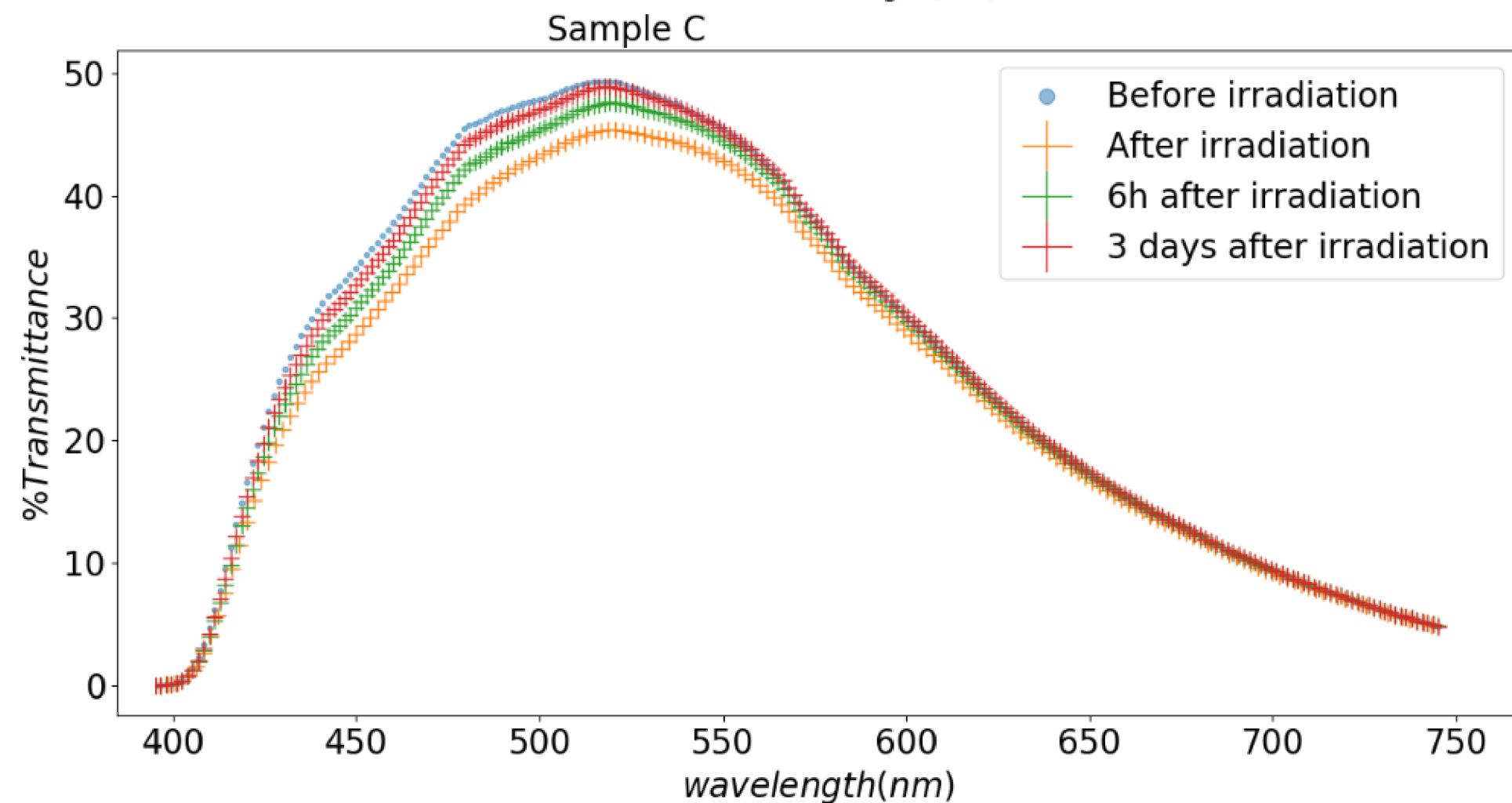
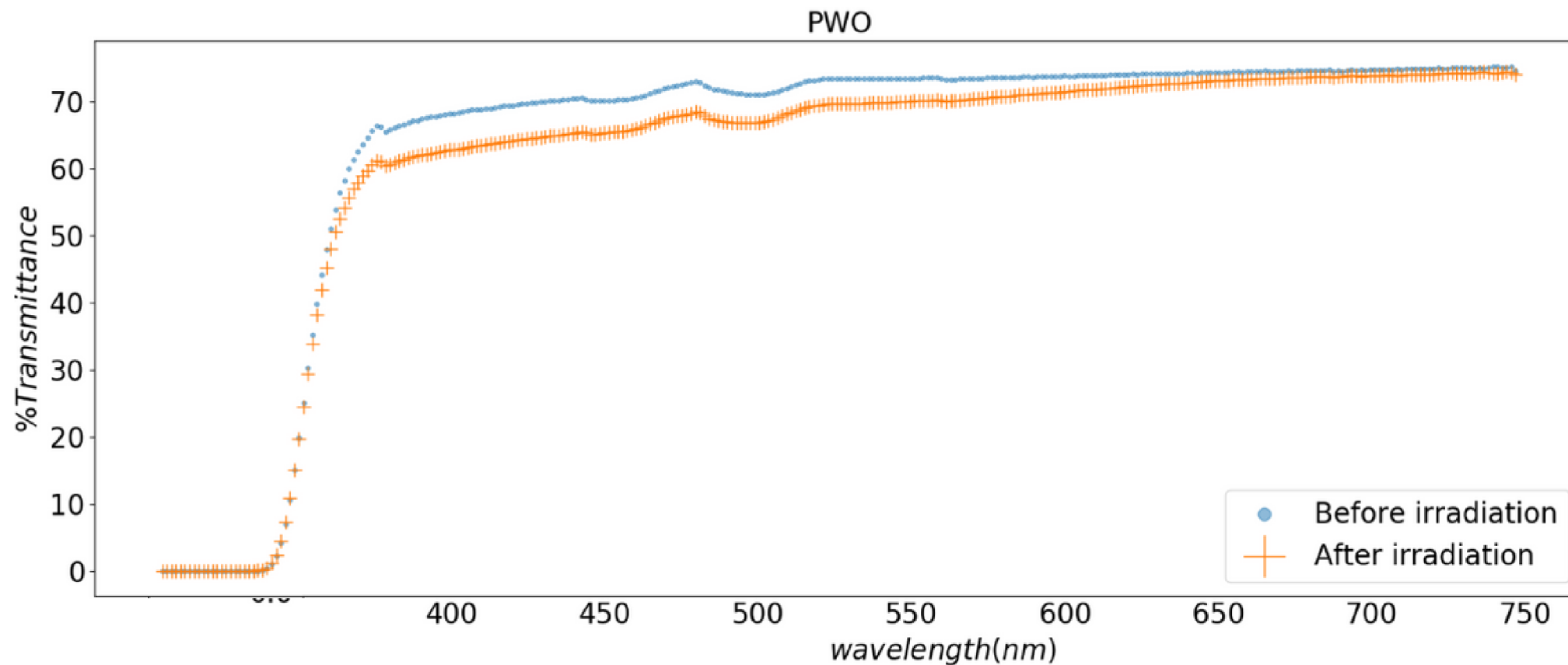
- Cost effective
- $X_0 = 22 - 28$ mm
- Tests of a few samples: 200 mm long, 20×20 mm²



Transmittance Measurement



Radiation Hardness

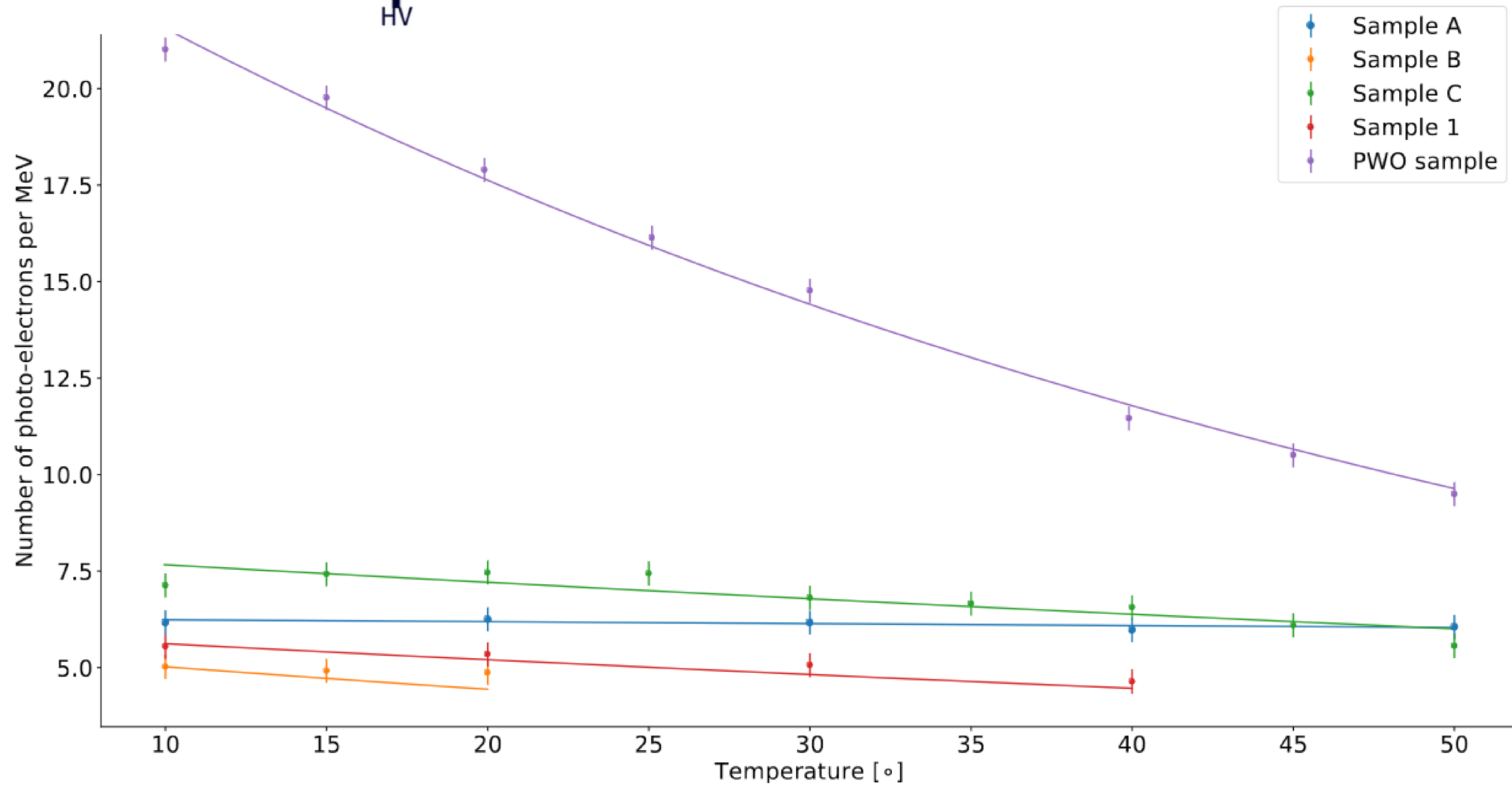
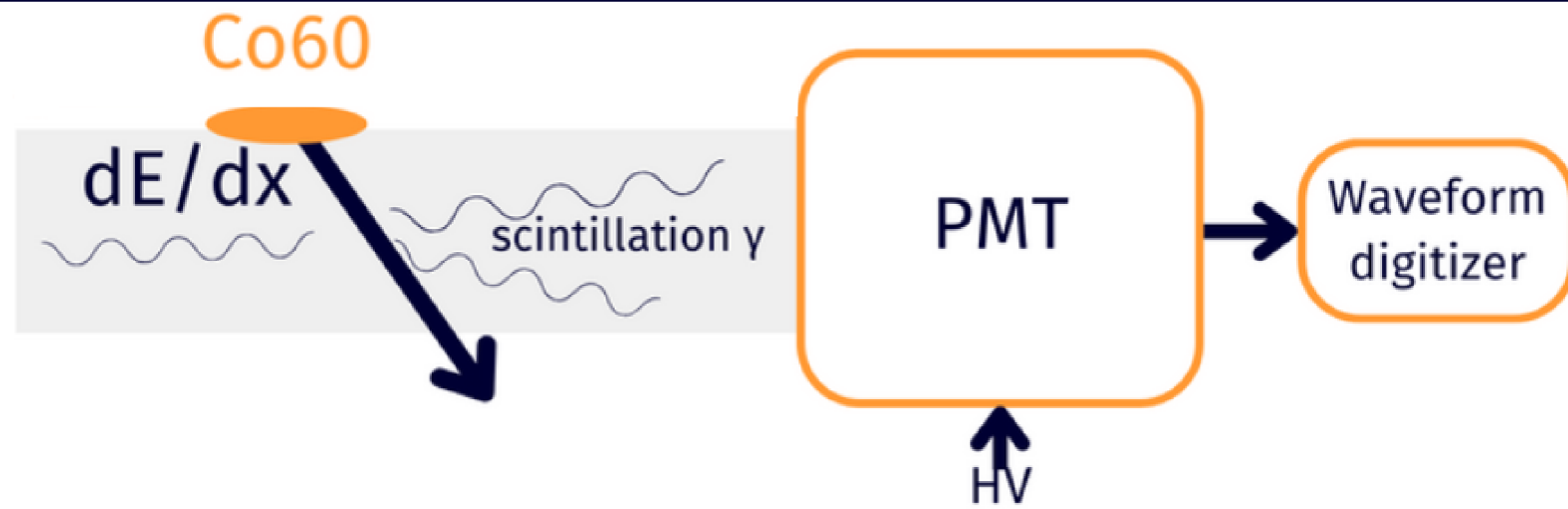


Transmittance measurement to assess the creation of light-absorbing centers with radiation damage.

Samples received a dose of 30Gy (1 year at the EIC) in 30 minutes.

- Both PWO and SciGlass resist well to radiation damage.
- Curing PWO crystals to recover from radiation damage is well-mastered.
- Most SciGlass samples were not damaged, and almost entirely recovered at room temperature, in the dark.
- Further tests were made with high doses, tests of annealing procedures showing excellent capabilities under radiation.

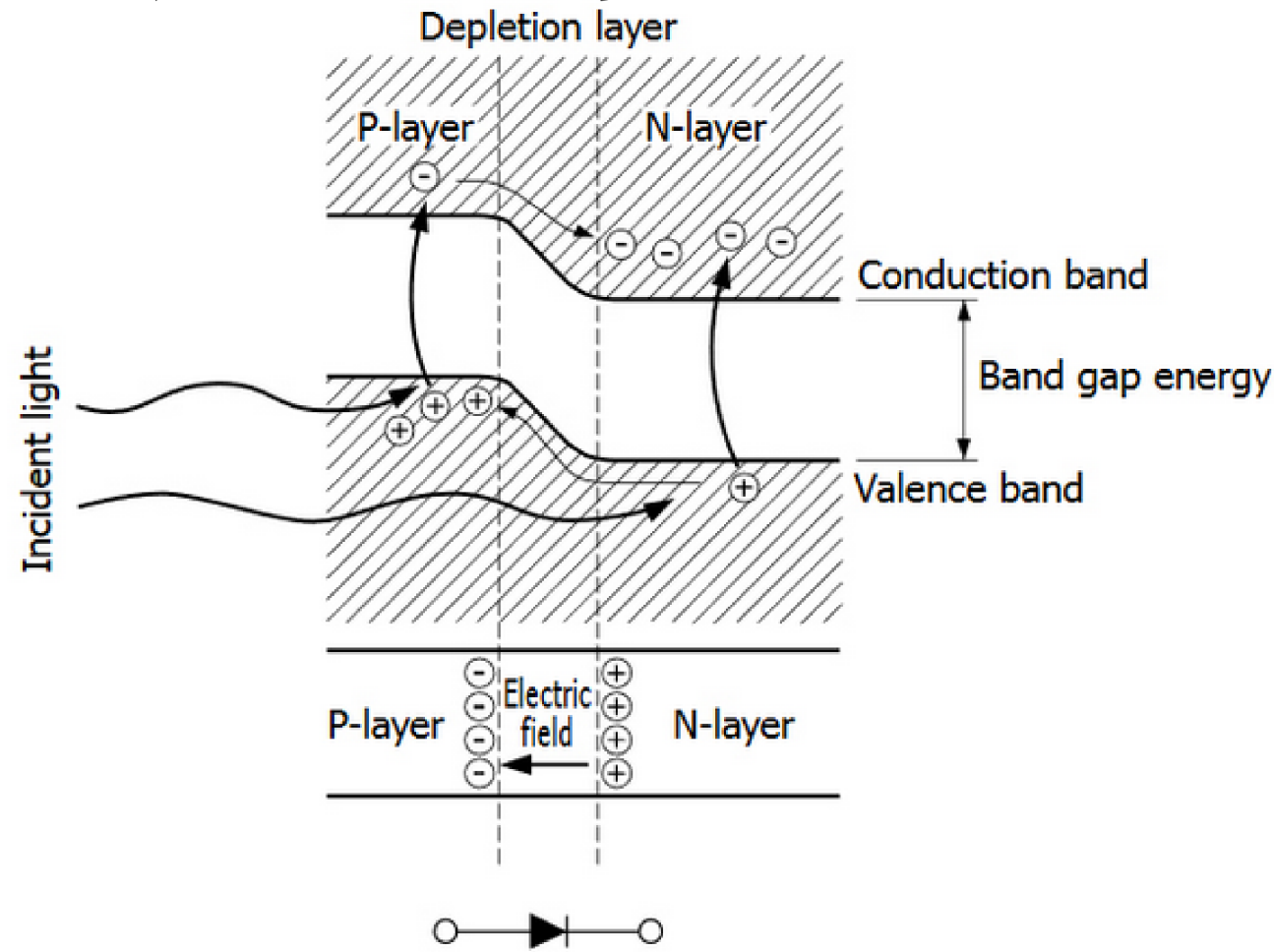
Light Yield



SiPM Readout

SiPMs

PN junction for photodetection



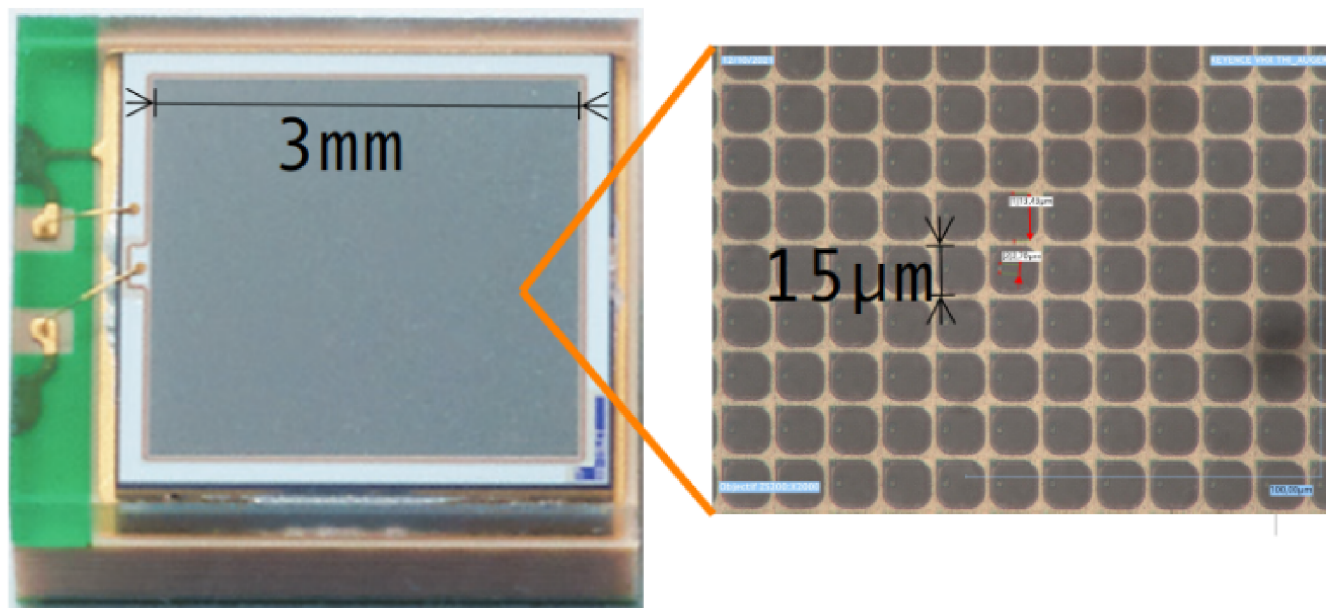
- Avalanche photodiode (APD):
External voltage \rightarrow avalanche phenomenon \rightarrow higher signal

- GAPD (Geiger mode):
Increasing $V \rightarrow e^-/h^+$ multiply faster than they can be extracted
 \rightarrow digital photodetector

- SiPM: a matrix of GAPDs !
All pixels are read in parallel \rightarrow analog detector
signal number of fired pixels “ ” incident number of γ

Main challenge for the SiPM readout is the dynamic range.

- Minimal detectable energy? Intrinsic noise in the SiPMs
- Non linearities at high energies?

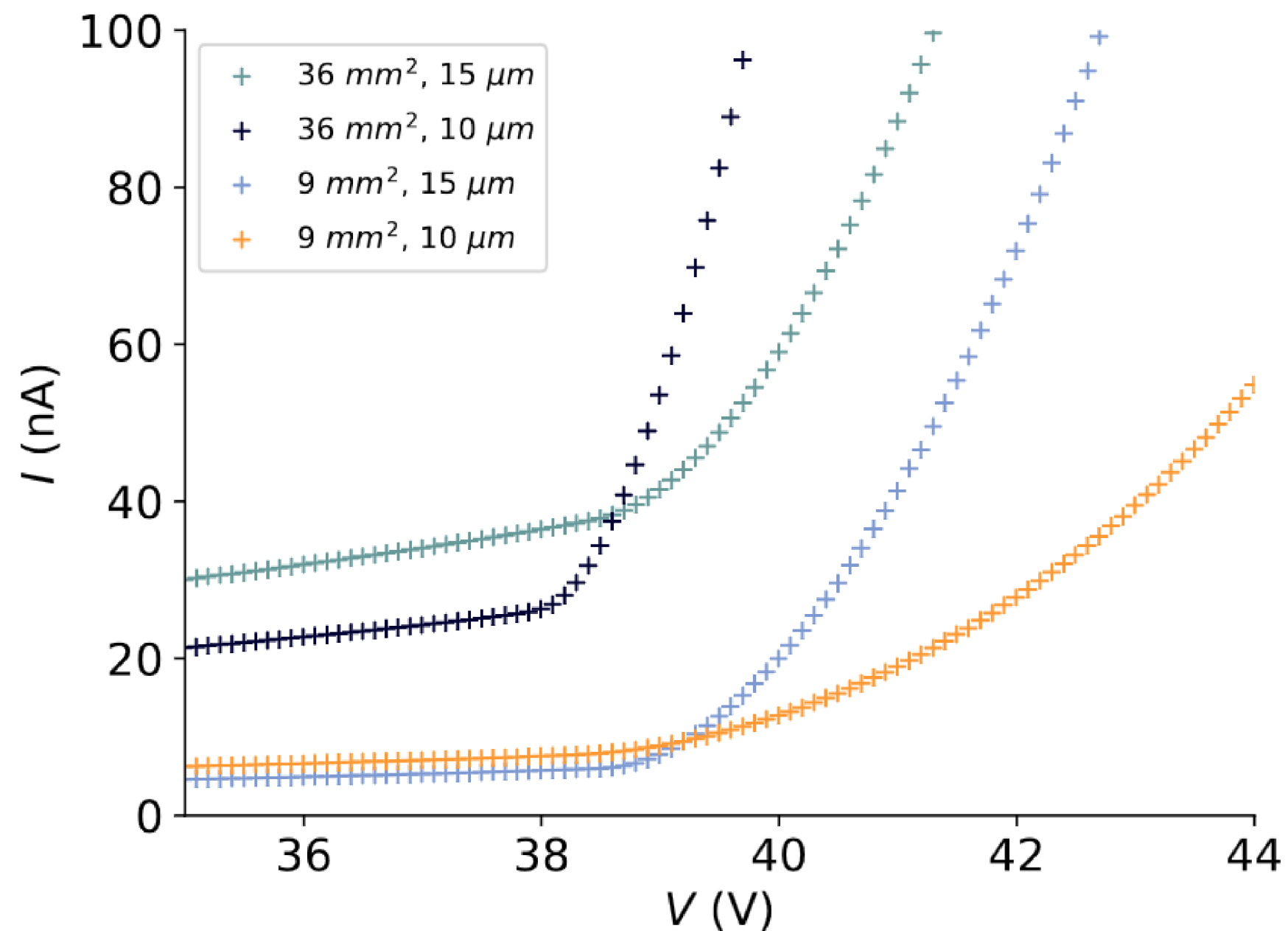


Surface [mm ²]	Pixel size [µm]	Number of pixels
36	10	359011
36	15	159565
9	10	89984
9	15	39984

Dark Noise Measurement

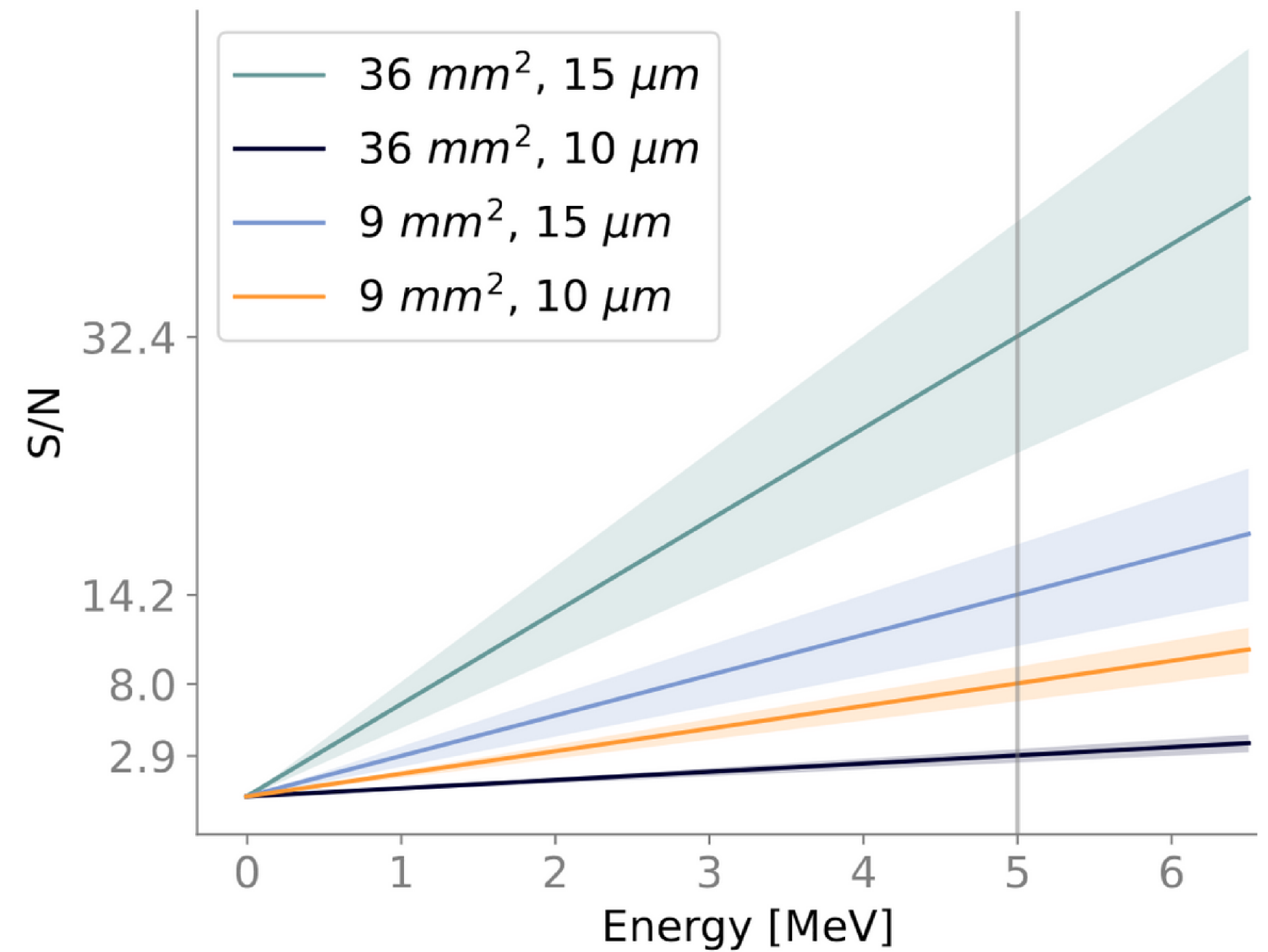
Limitation for low energy measurements: Dark Noise.

Reading output current for SiPMs in the dark



Comparing it to expected signal.

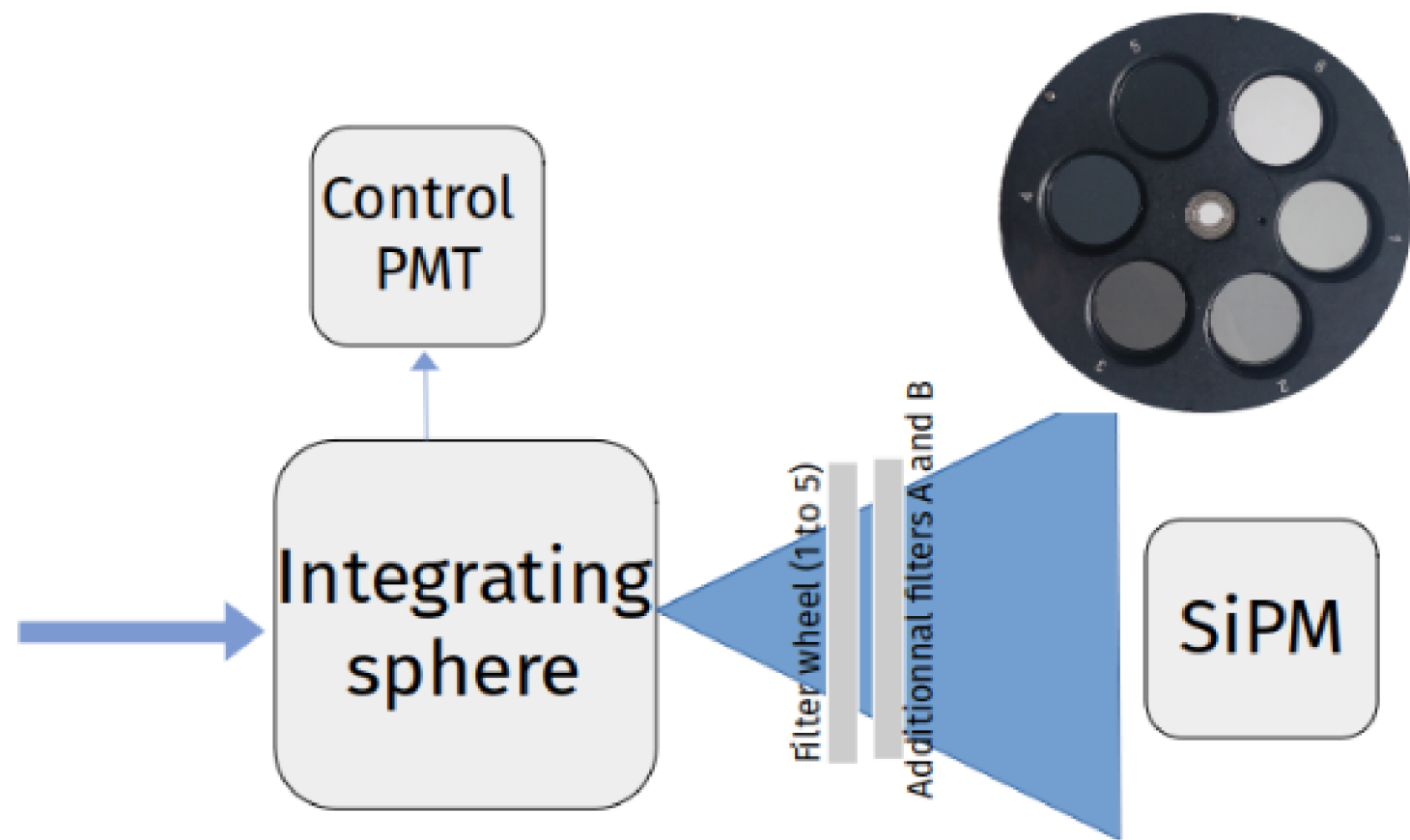
PWO's LY: 17 pe/MeV over the crystal surface



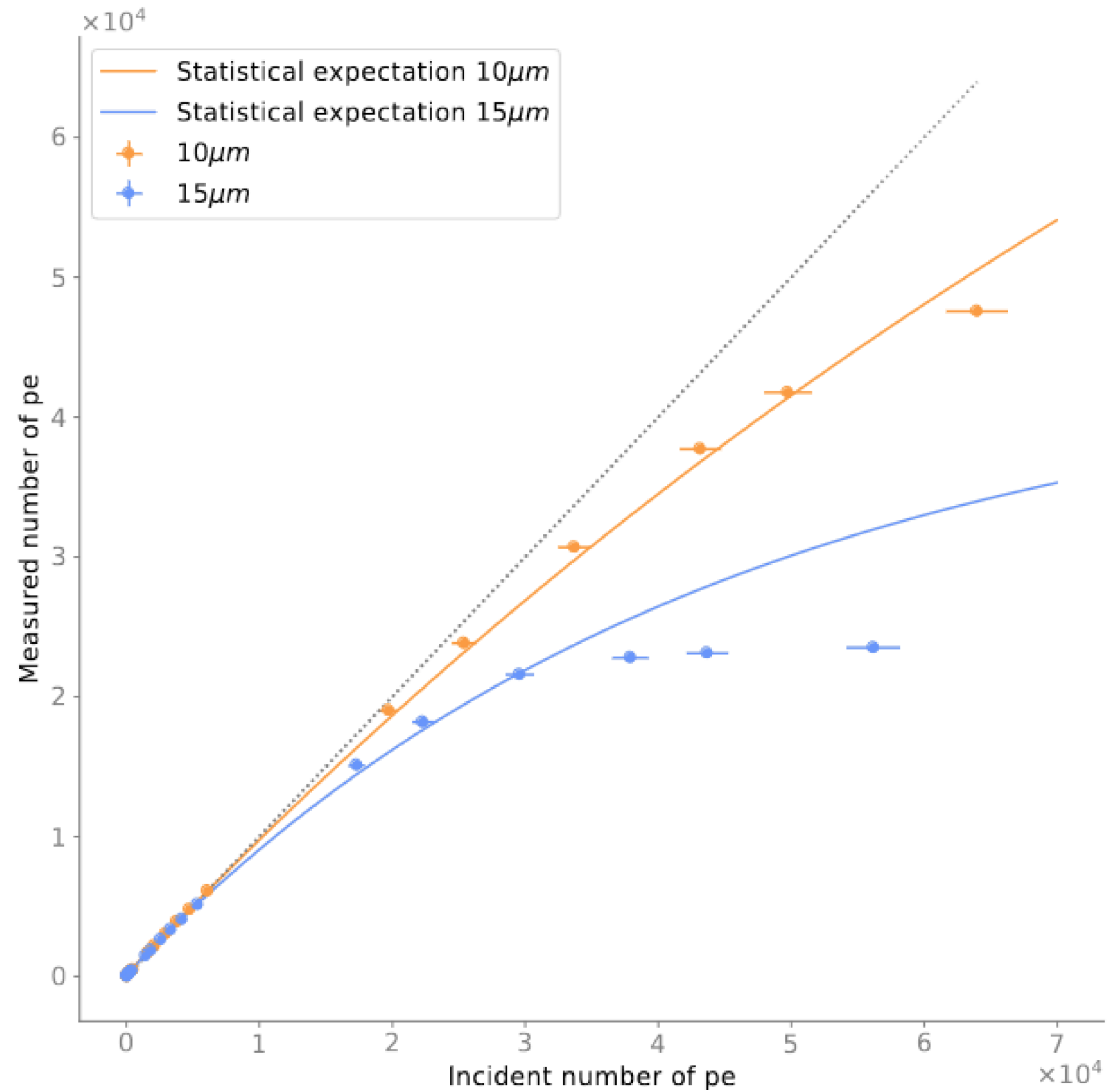
Linearity Measurement

Limitation for high energies: non linearities

For a high number of incident photons, there is a probability that more than one enters the same pixel



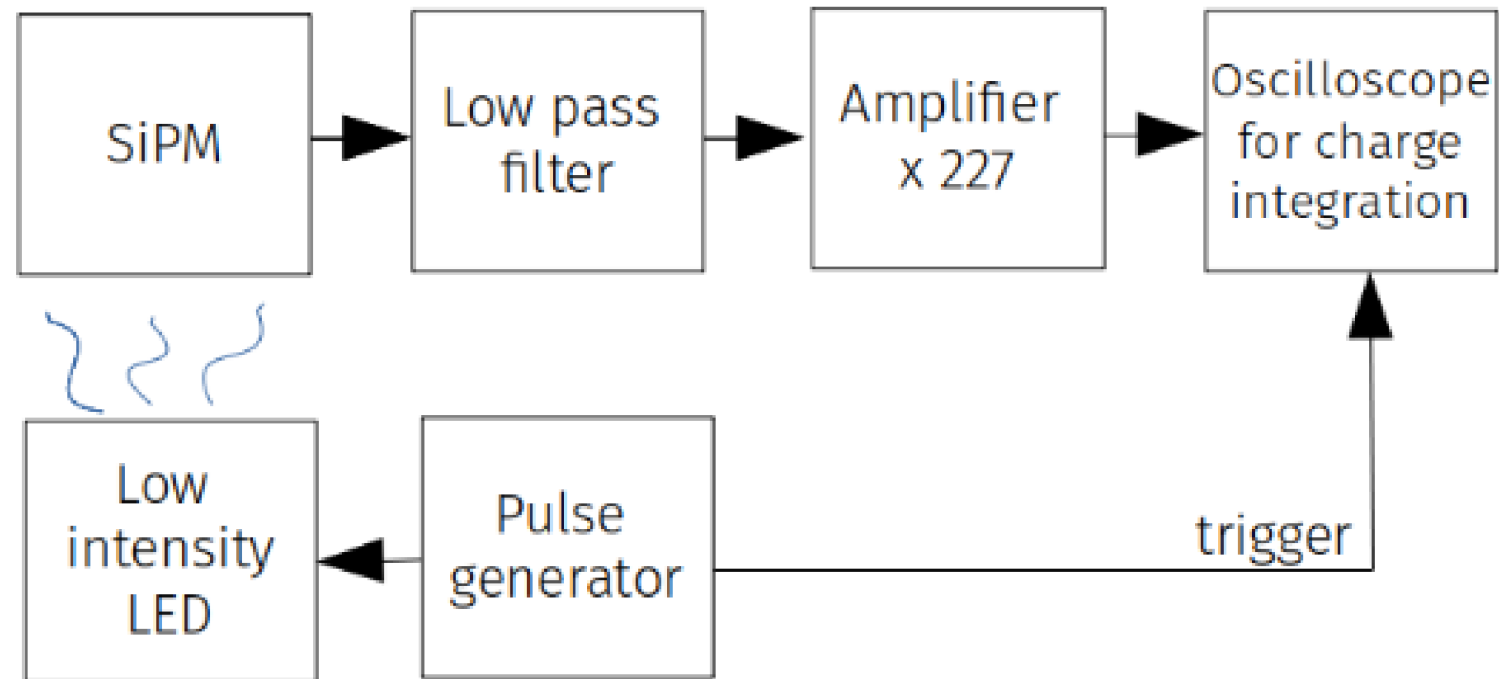
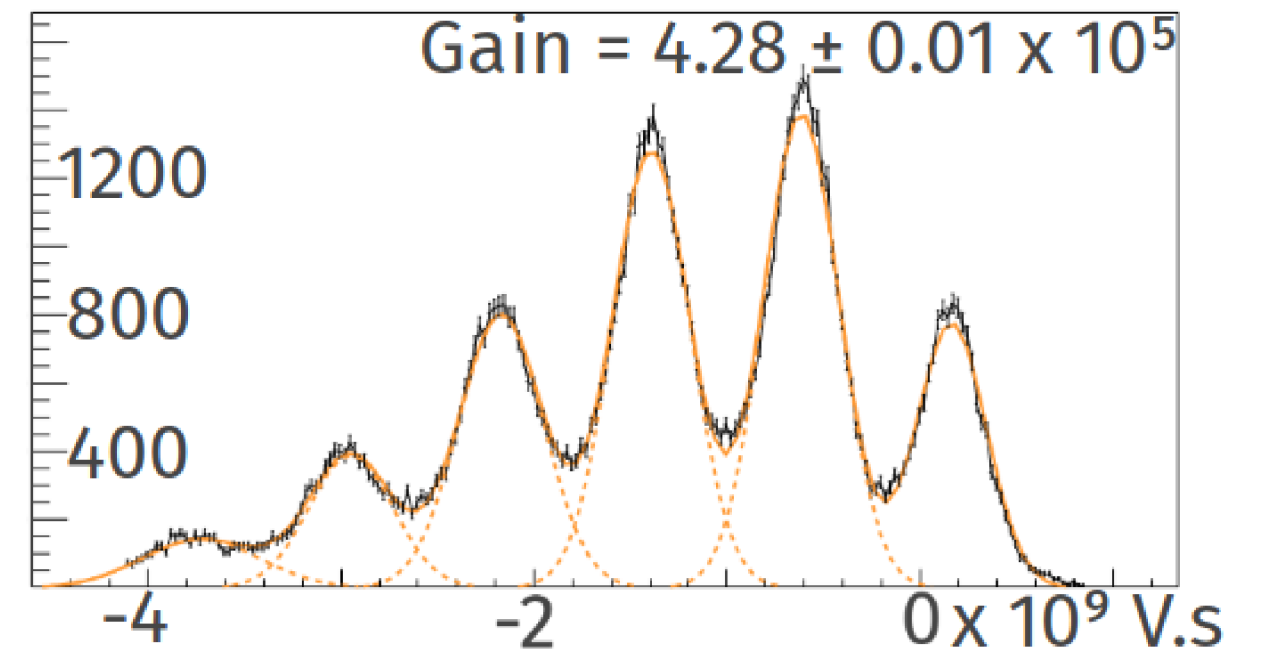
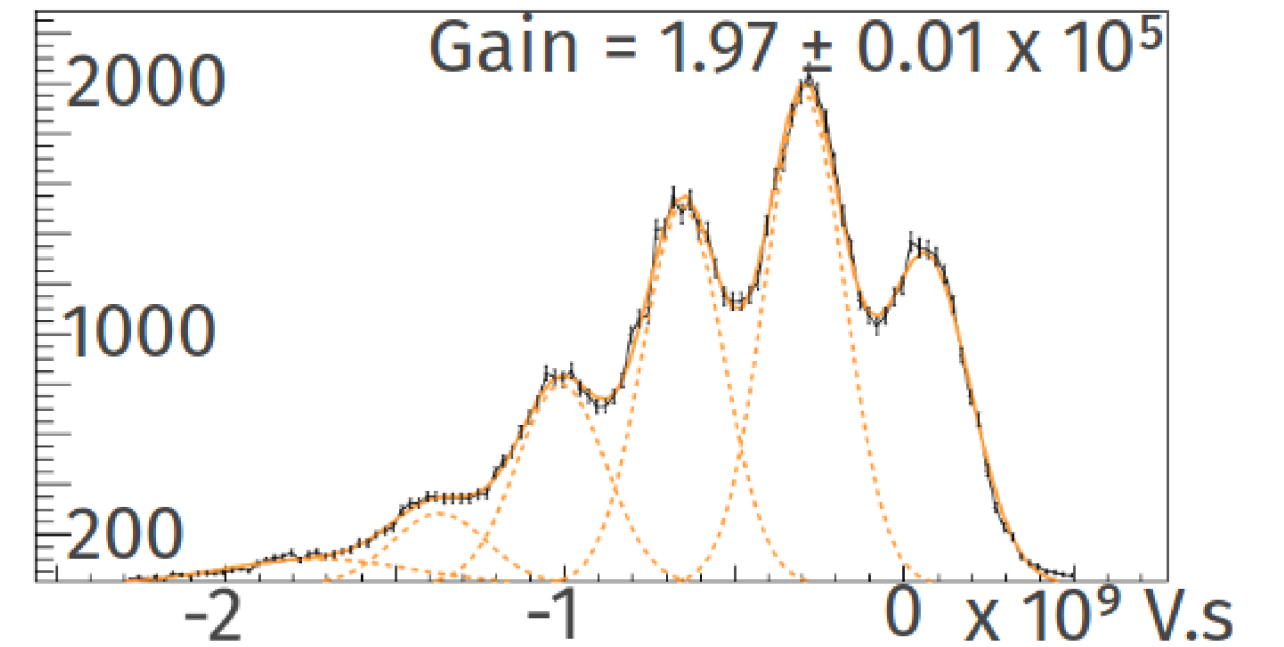
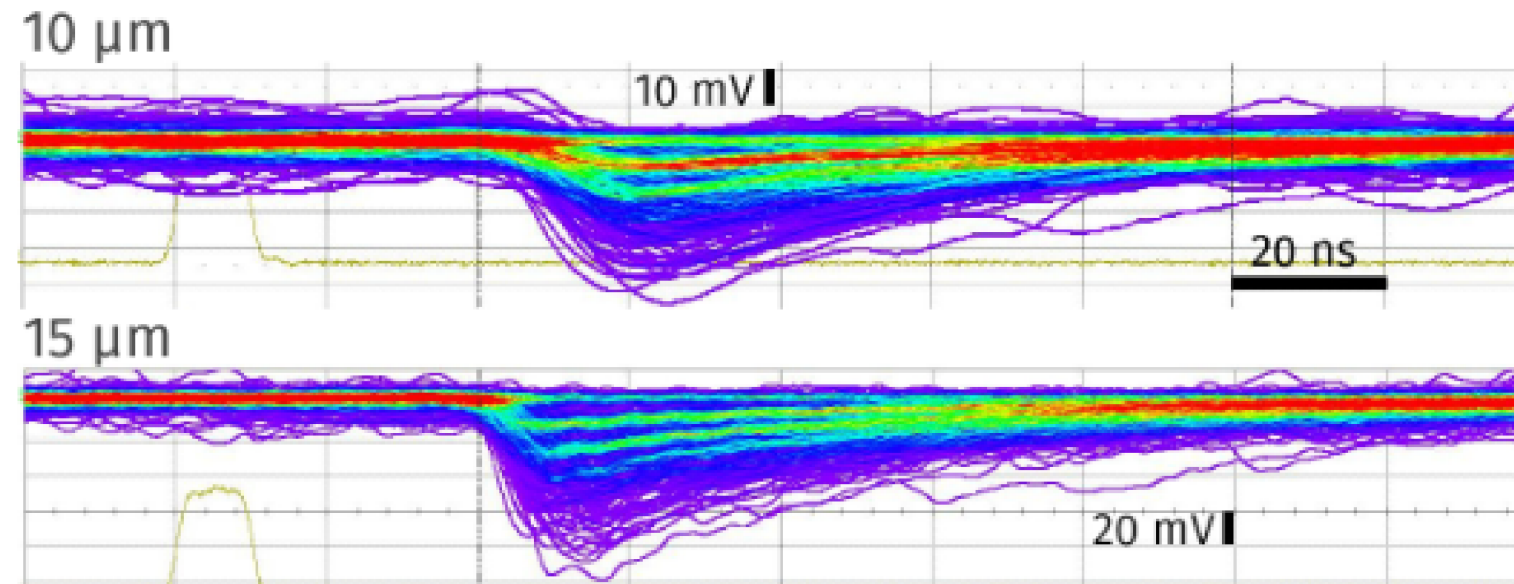
$$N_{detected} = N_{pixel} \left(1 - e^{-\frac{incident}{N_{pixel}}} \right)$$



Summary, Outlooks

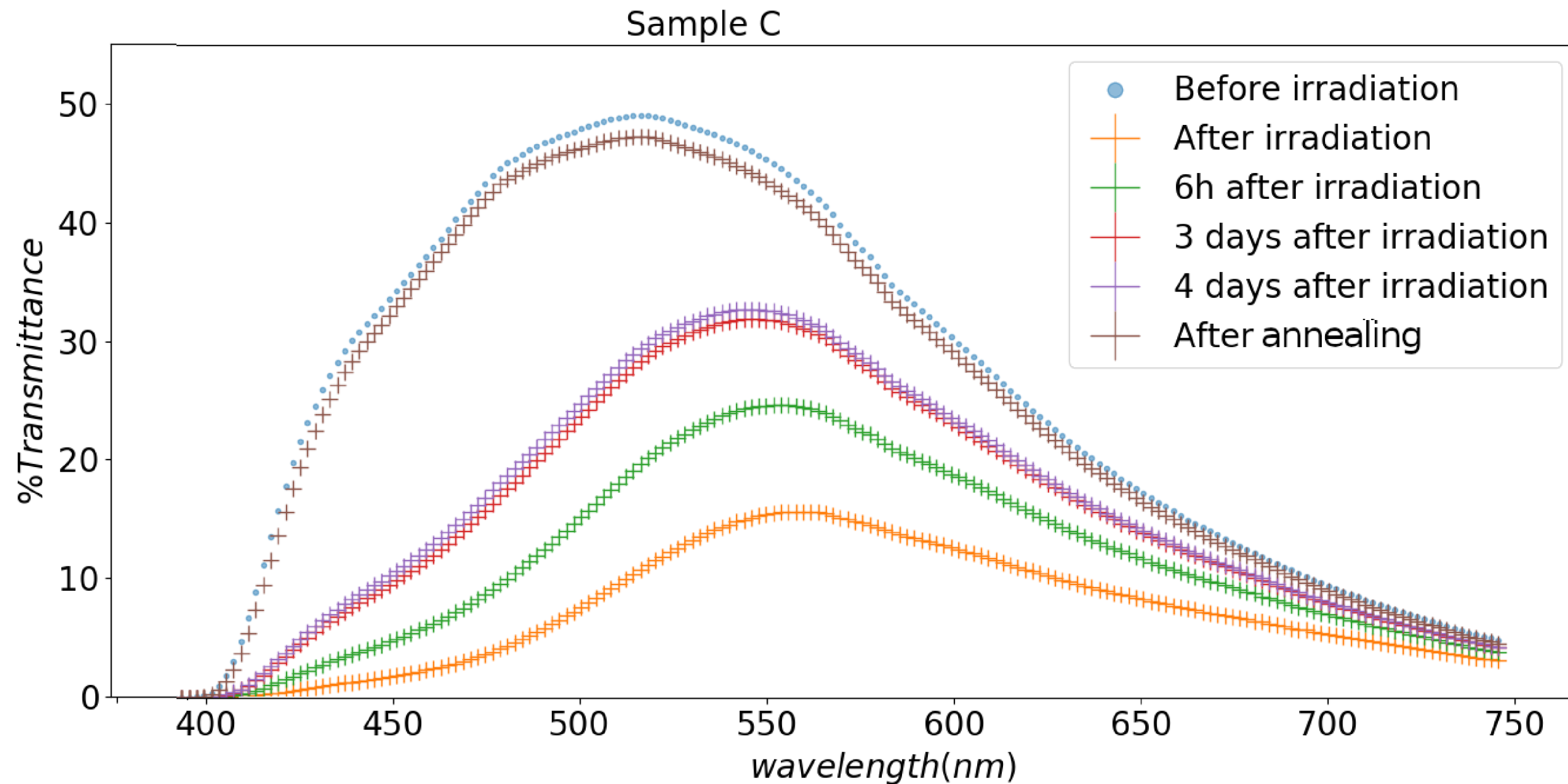
- Scattered electrons at the EIC will be detected in the EEMC with very good energy resolution and over a wide dynamic range.
- The EEMC will be comprised by bars of PWO crystals readout by SiPMs to measure scattered electrons at the EIC.
- PWO meets the requirements for energy resolution and radiation hardness.
- SciGlass was tested as an alternative, its development is ongoing and hold promises for future electromagnetic calorimeters.
- Testing of SiPMs validated this solution for the light readout of the EEMC.
- Choice between the different models is a compromise to be made between low and high energies capabilities.
- Tests with matrices of SiPMs are ongoing and will set the requirements for the electronics to be developed and the structure of the detector.
- Ongoing work at IJCLab and LLR/Omega: development of a specific ASIC for the readout, mechanical structure of the EEMC.

Gain Measurement



Radiation Hardness

- Further tests were made with high doses (180 Gy).
- Tests of annealing procedures.



Linearity Measurement

Limitation for high energies: non linearities

For a high number of incident photons, there is a probability that more than one enters the same pixel

$$N_{detected} = N_{pixel} \left(1 - e^{-\frac{incident}{N_{pixel}}} \right)$$

